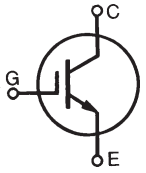
IXYS

Preliminary Technical Information

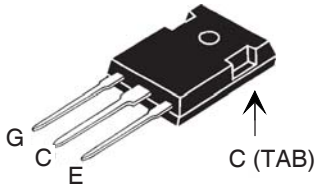
High Voltage IGBTs

IXGH6N170A
IXGT6N170A

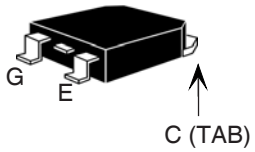
V_{CES} = 1700V
I_{C25} = 6A
$V_{CE(sat)}$ ≤ 7.0V
$t_{fi(typ)}$ = 32ns



TO-247 (IXGH)



TO-268 (IXGT)



G = Gate C = Collector
E = Emitter TAB = Collector

Symbol	Test Conditions	Maximum Ratings	
V_{CES}	T_C = 25°C to 150°C	1700	V
V_{CGR}	T_J = 25°C to 150°C, R_{GE} = 1MΩ	1700	V
V_{GES}	Continuous	± 20	V
V_{GEM}	Transient	± 30	V
I_{C25}	T_C = 25°C	6	A
I_{C110}	T_C = 110°C	3	A
I_{CM}	T_C = 25°C, 1ms	14	A
SSOA	V_{GE} = 15V, T_{VJ} = 125°C, R_G = 33Ω	I_{CM} = 12	A
(RBSOA)	Clamped Inductive Load	@ 0.8 • V_{CES}	
t_{SC}	T_J = 125°C, V_{CE} = 1200 V, V_{GE} = 15 V, R_G = 33Ω	10	µs
P_C	T_C = 25°C	75	W
T_J		- 55 ... +150	°C
T_{JM}		150	°C
T_{stg}		- 55 ... +150	°C
T_L	1.6mm (0.062 in.) from Case for 10s	300	°C
T_{SOLD}	Plastic Body for 10 seconds	260	°C
M_d	Mounting Torque (TO-247)	1.13/10	Nm/lb.in.
Weight	TO-247	6	g
	TO-268	4	g

Symbol	Test Conditions (T_J = 25°C Unless Otherwise Specified)	Characteristic Values Min.	Typ.	Max.	
BV_{CES}	I_C = 250µA, V_{GE} = 0V	1700			V
$V_{GE(th)}$	I_C = 250µA, V_{CE} = V_{GE}	3.0		5.0	V
I_{CES}	V_{CE} = 0.8 • V_{CES}, V_{GE} = 0V			10	µA
	T_J = 125°C			500	µA
I_{GES}	V_{CE} = 0V, V_{GE} = ± 20V			±100	nA
$V_{CE(sat)}$	I_C = I_{C110}, V_{GE} = 15V, Note 1			7.0	V
	T_J = 125°C		5.4		

Features

- International Standard Packages

Advantages

- High Power Density
- Low Gate Drive Requirement

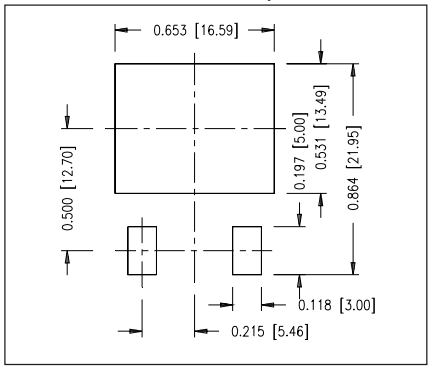
Applications

- Power Inverters
- UPS
- Motor Drives
- SMPS
- PFC Circuits
- Welding Machines

Symbol	Test Conditions (T_J = 25°C, Unless Otherwise Specified)	Characteristic Values Min.	Typ.	Max.	
g_{fs}	I_C = 6A, V_{CE} = 20V, Note 1	2.0	3.5		S
C_{ies}	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz		390		pF
C_{oes}			20		pF
C_{res}			7		pF
Q_g	I_C = 6A, V_{GE} = 15V, V_{CE} = 0.5 • V_{CES}		18.5		nC
Q_{ge}			2.8		nC
Q_{gc}			8.2		nC
$t_{d(on)}$	**Inductive load, T_J = 25°C**		46		ns
t_{ri}	I_C = 6A, V_{GE} = 15V		40		ns
E_{on}	V_{CE} = 0.5 • V_{CES}, R_G = 33Ω		0.59		mJ
$t_{d(off)}$	Note 1		220	400	ns
t_{fi}			32	65	ns
E_{off}			0.18	0.36	mJ
$t_{d(on)}$	**Inductive load, T_J = 125°C**		48		ns
t_{ri}	I_C = 6A, V_{GE} = 15V		43		ns
E_{on}	V_{CE} = 0.5 • V_{CES}, R_G = 33Ω		0.62		mJ
$t_{d(off)}$	Note 1		230		ns
t_{fi}			41		ns
E_{off}			0.25		mJ
R_{thJC}				1.65	°C/W
R_{thCK}			0.21		°C/W

Note 1: Pulse Test, t ≤ 300μs, Duty Cycle, d ≤ 2%.

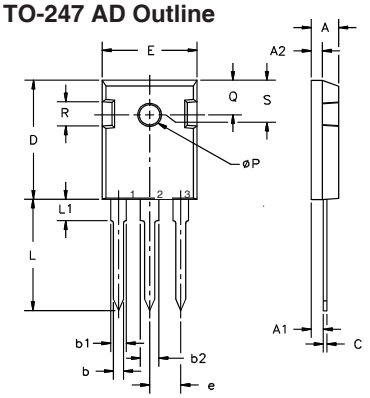
Min Recommended Footprint



PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

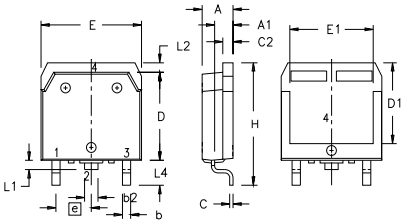
TO-247 AD Outline



Terminals: 1 - Gate 2 - Drain

Dim.	Millimeter Min.	Max.	Inches Min.	Max.
A	4.7	5.3	.185	.209
A_1	2.2	2.54	.087	.102
A_2	2.2	2.6	.059	.098
b	1.0	1.4	.040	.055
b_1	1.65	2.13	.065	.084
b_2	2.87	3.12	.113	.123
C	.4	.8	.016	.031
D	20.80	21.46	.819	.845
E	15.75	16.26	.610	.640
e	5.20	5.72	0.205	0.225
L	19.81	20.32	.780	.800
L1		4.50		.177
øP	3.55	3.65	.140	.144
Q	5.89	6.40	0.232	0.252
R	4.32	5.49	.170	.216

TO-268 Outline



Terminals: 1 - Gate 2 - Drain

SYM	INCHES MIN	MAX	MILLIMETERS MIN	MAX
A	.193	.201	4.90	5.10
A1	.106	.114	2.70	2.90
A2	.001	.010	0.02	0.25
b	.045	.057	1.15	1.45
b2	.075	.083	1.90	2.10
C	.016	.026	0.40	0.65
C2	.057	.063	1.45	1.60
D	.543	.551	13.80	14.00
D1	.488	.500	12.40	12.70
E	.624	.632	15.85	16.05
E1	.524	.535	13.30	13.60
e	.215 BSC		5.45 BSC	
H	.736	.752	18.70	19.10
L	.094	.106	2.40	2.70
L1	.047	.055	1.20	1.40
L2	.039	.045	1.00	1.15
L3	.010 BSC		0.25 BSC	
L4	.150	.161	3.80	4.10

Fig. 1. Output Characteristics @ 25ºC

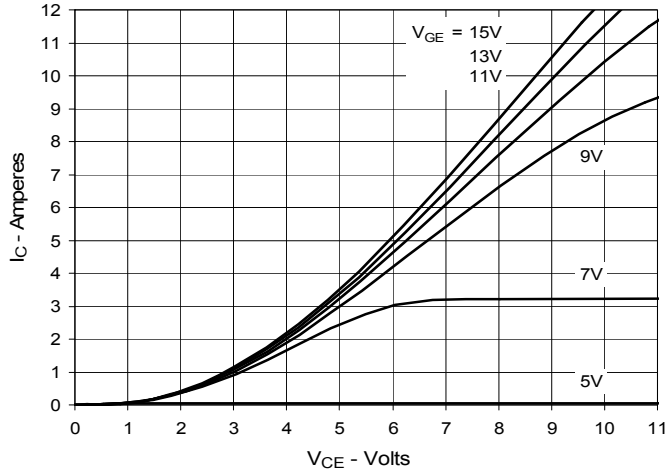


Fig. 2. Extended Output Characteristics @ 25ºC

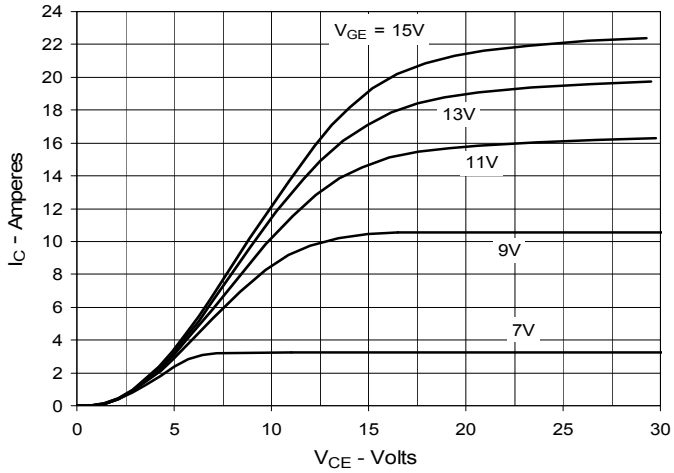


Fig. 3. Output Characteristics @ 125ºC

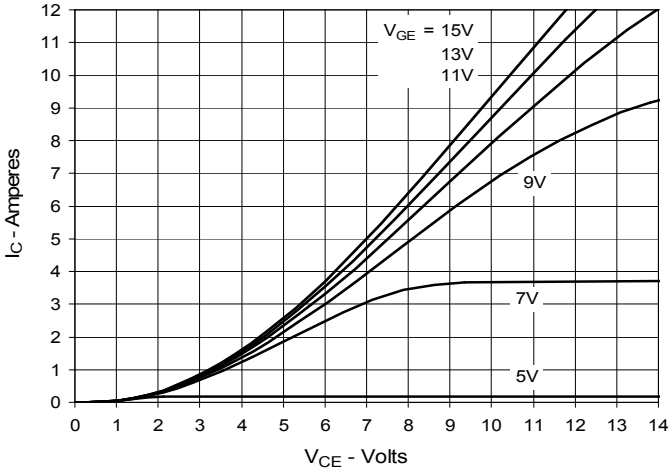


Fig. 4. Dependence of $V_{CE(sat)}$ on Junction Temperature

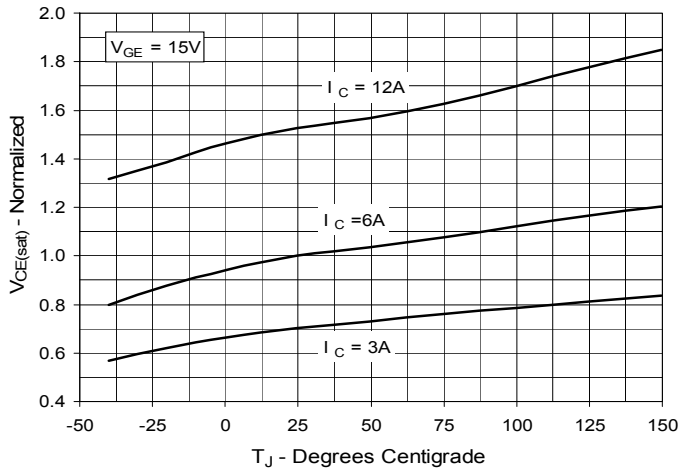


Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage

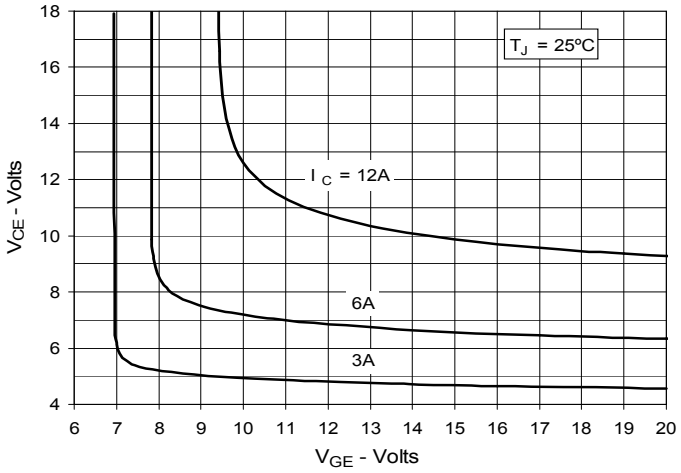


Fig. 6. Input Admittance

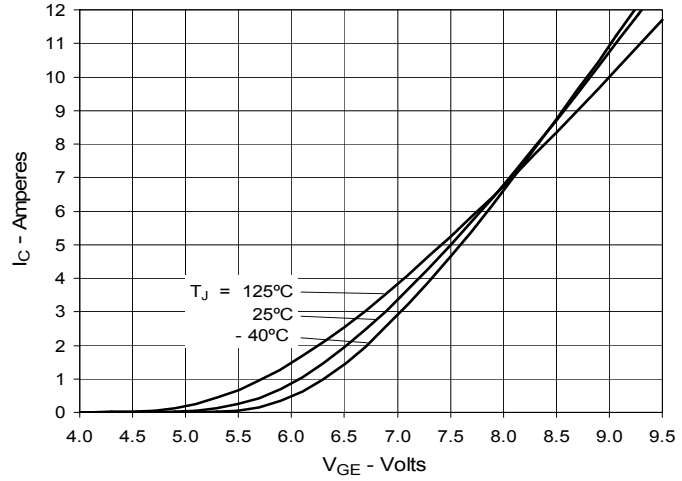


Fig. 7. Transconductance

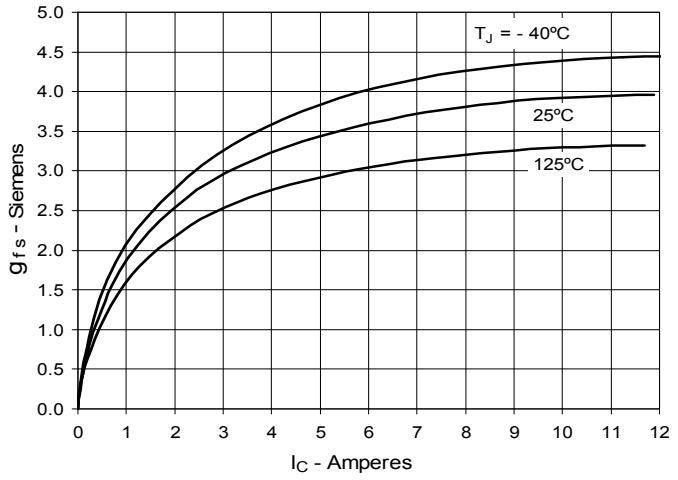


Fig. 8. Gate Charge

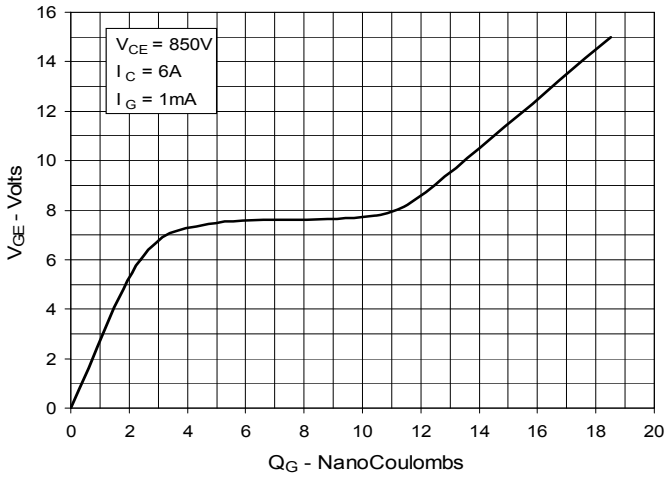


Fig. 9. Reverse-Bias Safe Operating Area

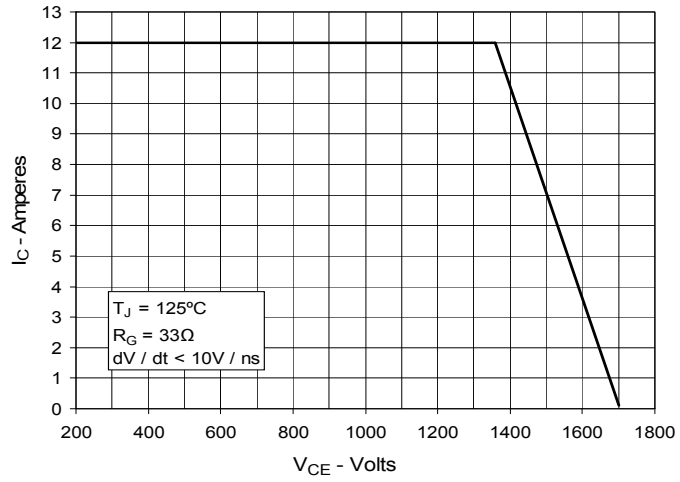


Fig. 10. Capacitance

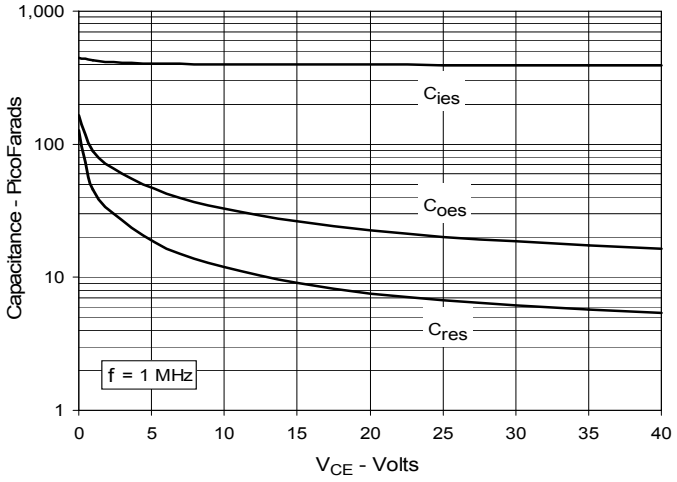


Fig. 11. Maximum Transient Thermal Impedance

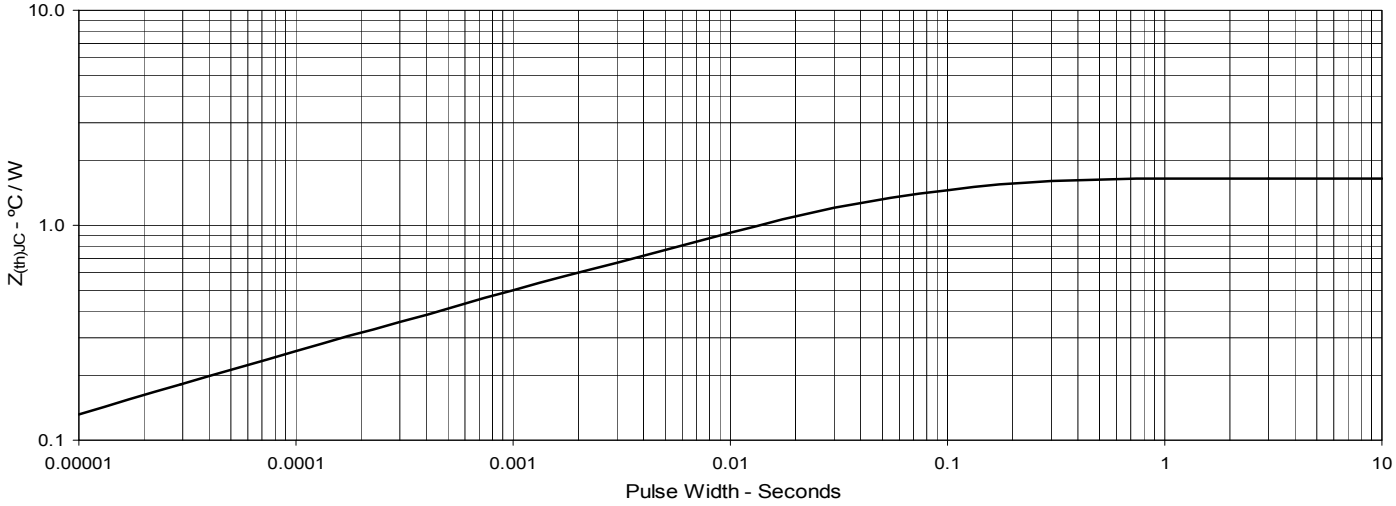


Fig. 12. Inductive Switching Energy Loss vs. Gate Resistance

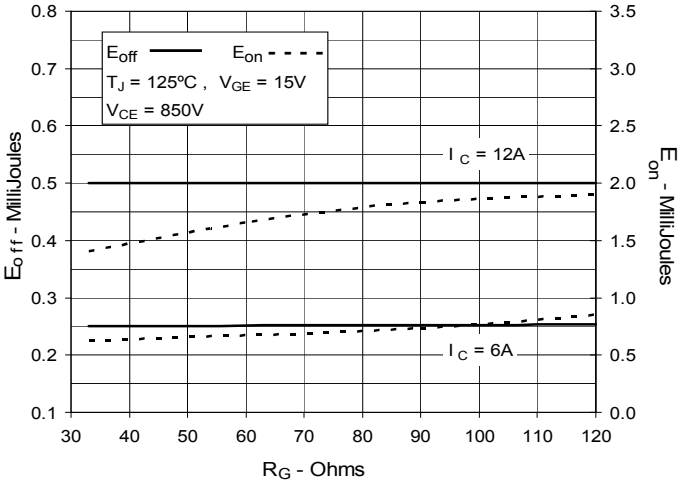


Fig. 13. Inductive Switching Energy Loss vs. Collector Current

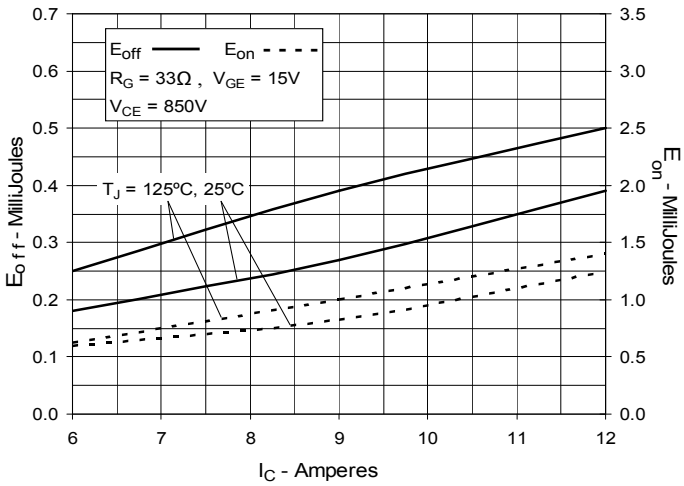


Fig. 14. Inductive Switching Energy Loss vs. Junction Temperature